

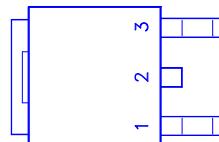
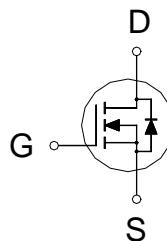
NIKO-SEM
**N-Channel Logic Level Enhancement
Mode Field Effect Transistor**
P4506BD

TO-252

Halogen-Free & Lead-Free

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
60	45mΩ	22A

**ABSOLUTE MAXIMUM RATINGS ($T_c = 25^\circ\text{C}$ Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	60	V
Gate-Source Voltage	V_{GS}	± 20	V
Continuous Drain Current	I_D	22	A
		18	
Pulsed Drain Current ¹	I_{DM}	80	
Power Dissipation	P_D	42	W
		27	
Operating Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150	$^\circ\text{C}$
Lead Temperature (1/16" from case for 10 sec.)	T_L	275	

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		3	$^\circ\text{C} / \text{W}$
Junction-to-Ambient	$R_{\theta JA}$		75	$^\circ\text{C} / \text{W}$

¹Pulse width limited by maximum junction temperature.
ELECTRICAL CHARACTERISTICS ($T_c = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu\text{A}$	60			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	1	1.5	3.0	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 20V$			± 250	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 48V, V_{GS} = 0V$			1	
		$V_{DS} = 40V, V_{GS} = 0V, T_J = 55^\circ\text{C}$			10	μA

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On-State Drain Current ¹	I _{D(ON)}	V _{DS} = 5V, V _{GS} = 10V	80			A
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} = 5V, I _D = 10A		42	60	mΩ
		V _{GS} = 10V, I _D = 15A		35	45	
Forward Transconductance ¹	g _{fs}	V _{DS} = 10V, I _D = 15A		15		S

DYNAMIC						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz		790		pF
Output Capacitance	C _{oss}			98		
Reverse Transfer Capacitance	C _{rss}			42		
Total Gate Charge ²	Q _g	V _{DS} = 0.5V _{(BR)DSS} , V _{GS} = 10V, I _D = 5A		15.2	22	nC
Gate-Source Charge ²	Q _{gs}			2.9		
Gate-Drain Charge ²	Q _{gd}			3.2		
Turn-On Delay Time ²	t _{d(on)}	V _{DD} = 30V I _D ≈ 1A, V _{GS} = 10V, R _{GEN} = 6Ω		13.5	24	nS
Rise Time ²	t _r			9.8	18	
Turn-Off Delay Time ²	t _{d(off)}			23	40	
Fall Time ²	t _f			7.2	16	
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T _c = 25 °C)						
Continuous Current	I _S				15	A
Forward Voltage ¹	V _{SD}	I _F = I _S , V _{GS} = 0V			1.3	V

¹Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.²Independent of operating temperature.

REMARK: THE PRODUCT MARKED WITH "P4506BD", DATE CODE or LOT #

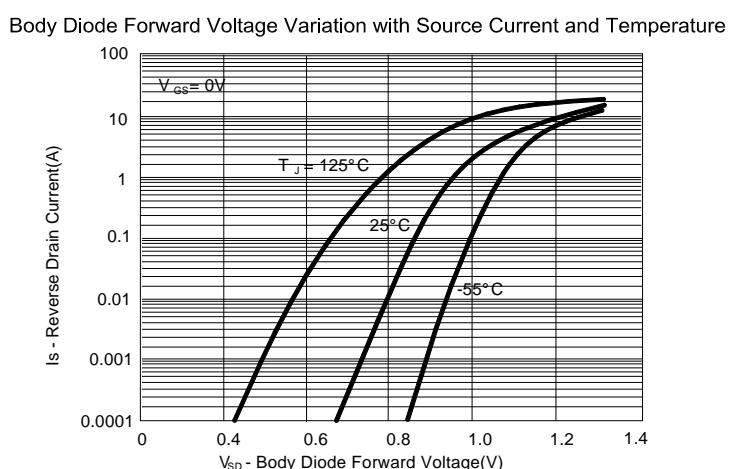
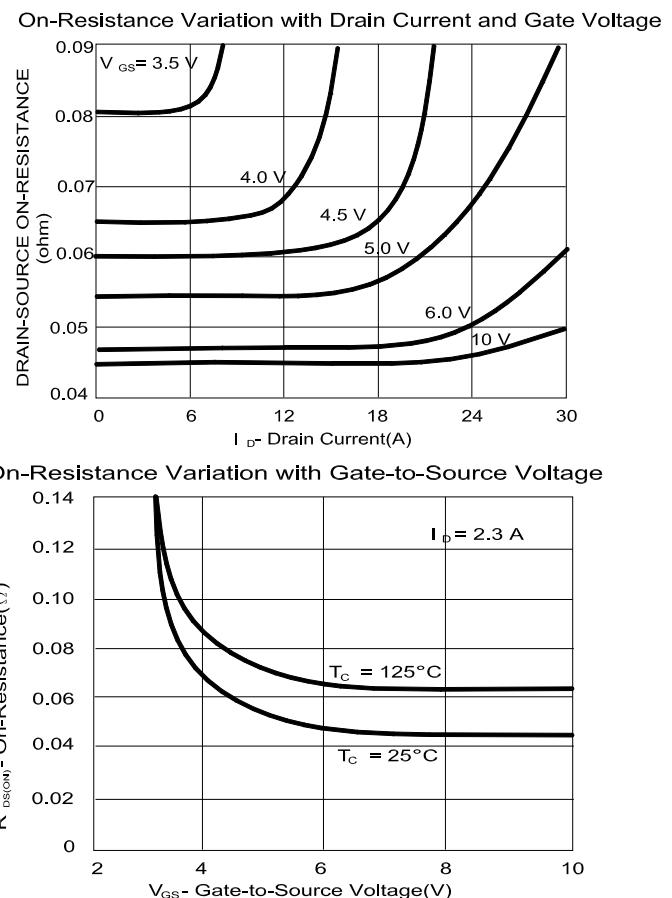
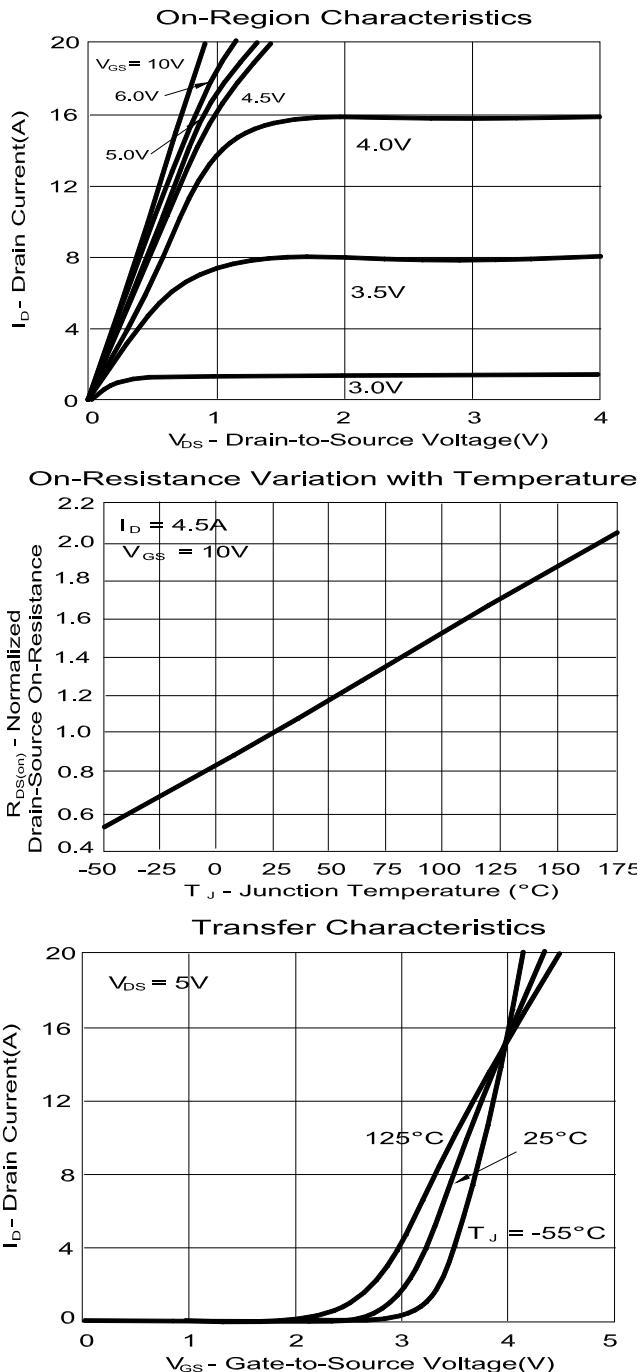
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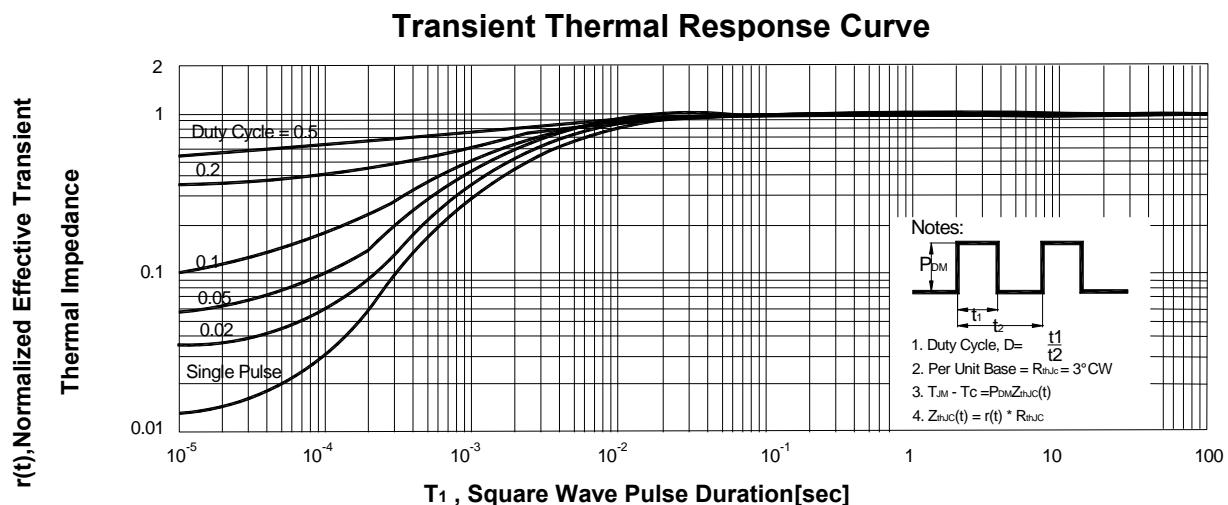
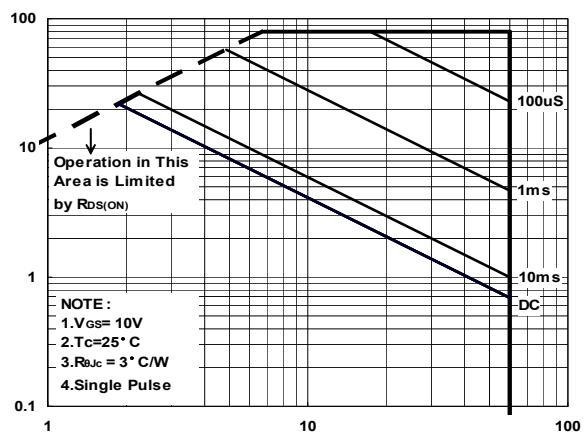
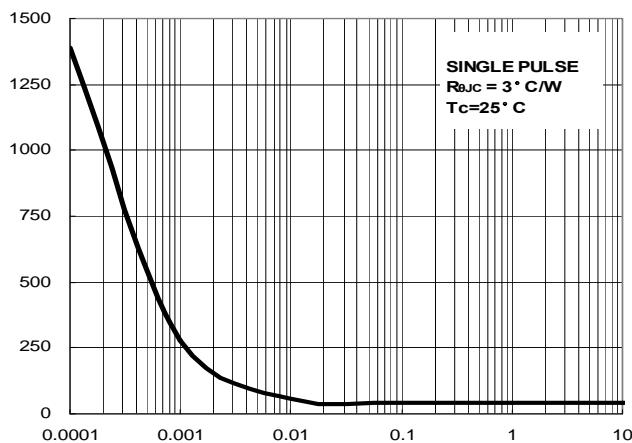
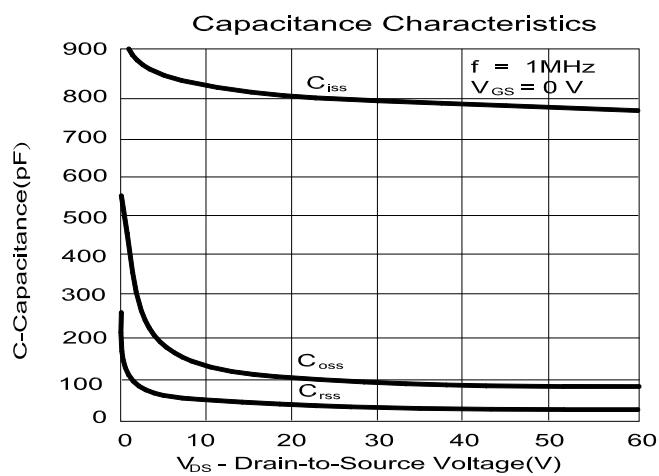
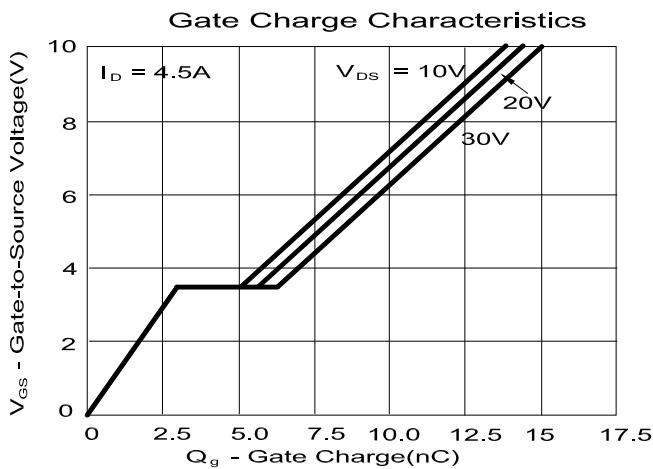
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TO-252 (DPAK) MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	8.9	9.5	10.4	H	0.8	1.27	2.03
B	2.19	2.3	2.435	I	6.35	6.6	6.8
C	0.35	0.5	0.65	J	4.8	5.34	5.5
D	0.89		1.5	K	0.5		1.5
E	0.35		0.65	L	0.4	0.76	0.89
F	0.0		0.23	M	3.96		5.18
G	5.4		6.2	N			

